May 2017

# H11A1M 6-Pin General Purpose Phototransistor Optocoupler

#### **Features**

- Minimum Current Transfer Ratio, 50 % at I  $_{\text{F}}$  = 10 mA,  $V_{\text{CE}}$  = 10 V
- · Safety and Regulatory Approvals:
  - UL1577, 4,170 VAC<sub>RMS</sub> for 1 Minute
  - DIN-EN/IEC60747-5-5, 850 V Peak Working Insulation Voltage

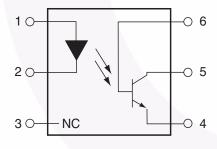
### **Applications**

- · Power Supply Regulators
- · Digital Logic Inputs
- Microprocessor Inputs

### **Description**

The general purpose optocoupler consists of a gallium arsenide infrared emitting diode driving a silicon phototransistor in a standard plastic six-pin dual-in-line package.

## **Schematic**



- PIN 1. ANODE
  - 2. CATHODE
  - 3. NO CONNECTION
  - 4. EMITTER
  - 5. COLLECTOR
  - 6. BASE

Figure 1. Schematic

## **Package Outlines**

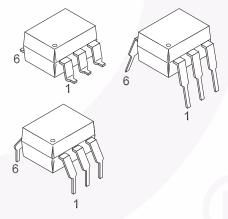


Figure 2. Package Outlines

## **Safety and Insulation Ratings**

As per DIN EN/IEC 60747-5-5, this optocoupler is suitable for "safe electrical insulation" only within the safety limit data. Compliance with the safety ratings shall be ensured by means of protective circuits.

| Parameter                                  |                        | Characteristics |
|--|------------------------|-----------------|
| Installation Classifications per DIN VDE   | < 150 V <sub>RMS</sub> | I–IV            |
| 0110/1.89 Table 1, For Rated Mains Voltage | < 300 V <sub>RMS</sub> | I–IV            |
| Climatic Classification                    |                        | 55/100/21       |
| Pollution Degree (DIN VDE 0110/1.89)       |                        | 2               |
| Comparative Tracking Index                 |                        | 175             |

| Symbol                | Parameter  | Value             | Unit              |
|-----------------------|--|-------------------|-------------------|
| V                     | Input-to-Output Test Voltage, Method A, $V_{IORM}$ x 1.6 = $V_{PR}$ , Type and Sample Test with $t_m$ = 10 s, Partial Discharge < 5 pC                         | 1360              | V <sub>peak</sub> |
| V <sub>PR</sub>       | Input-to-Output Test Voltage, Method B, V <sub>IORM</sub> x 1.875 = V <sub>PR</sub> , 100% Production Test with t <sub>m</sub> = 1 s, Partial Discharge < 5 pC | 1594              | V <sub>peak</sub> |
| V <sub>IORM</sub>     | Maximum Working Insulation Voltage   | 850               | V <sub>peak</sub> |
| V <sub>IOTM</sub>     | Highest Allowable Over-Voltage   | 6000              | V <sub>peak</sub> |
|                       | External Creepage  | ≥ 7               | mm                |
|                       | External Clearance   | ≥ 7               | mm                |
|                       | External Clearance (for Option TV, 0.4" Lead Spacing)  | ≥ 10              | mm                |
| DTI                   | Distance Through Insulation (Insulation Thickness)   | ≥ 0.5             | mm                |
| T <sub>S</sub>        | Case Temperature <sup>(1)</sup>  | 175               | °C                |
| I <sub>S,INPUT</sub>  | Input Current <sup>(1)</sup>   | 350               | mA                |
| P <sub>S,OUTPUT</sub> | Output Power <sup>(1)</sup>  | 800               | mW                |
| R <sub>IO</sub>       | Insulation Resistance at T <sub>S</sub> , V <sub>IO</sub> = 500 V <sup>(1)</sup>   | > 10 <sup>9</sup> | Ω                 |

#### Note:

1. Safety limit values – maximum values allowed in the event of a failure.

## **Absolute Maximum Ratings**

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.  $T_A = 25^{\circ}$ C unless otherwise specified.

| Symbol              | Parameter  | Value              | Unit  |
|---------------------|--|--------------------|-------|
| TOTAL DEV           | CICE   |                    |       |
| T <sub>STG</sub>    | Storage Temperature                                    | -40 to +125        | °C    |
| T <sub>OPR</sub>    | Operating Temperature                                  | -40 to +100        | °C    |
| T <sub>J</sub>      | Junction Temperature                                   | -40 to +125        | °C    |
| T <sub>SOL</sub>    | Lead Solder Temperature                                | 260 for 10 seconds | °C    |
|                     | Total Device Power Dissipation @ T <sub>A</sub> = 25°C | 270                | mW    |
| $P_{D}$             | Derate Above 25°C                                      | 2.94               | mW/°C |
| EMITTER             |  |                    |       |
| I <sub>F</sub>      | DC/Average Forward Input Current                       | 60                 | mA    |
| V <sub>R</sub>      | Reverse Input Voltage                                  | 6                  | V     |
| I <sub>F</sub> (pk) | Forward Current – Peak (300 µs, 2% Duty Cycle)         | 3                  | Α     |
| Ъ                   | LED Power Dissipation @ T <sub>A</sub> = 25°C          | 120                | mW    |
| P <sub>D</sub>      | Derate Above 25°C                                      | 1.41               | mW/°C |
| DETECTOR            |  |                    |       |
| $V_{CEO}$           | Collector-to-Emitter Voltage                           | 30                 | V     |
| V <sub>CBO</sub>    | Collector-to-Base Voltage                              | 70                 | V     |
| V <sub>ECO</sub>    | Emitter-to-Collector Voltage                           | 7                  | V     |
|                     | Detector Power Dissipation @ T <sub>A</sub> = 25°C     | 150                | mW    |
| $P_{D}$             | Derate Above 25°C                                      | 1.76               | mW/°C |

### **Electrical Characteristics**

TA = 25°C unless otherwise specified.

### **Individual Component Characteristics**

| Symbol            | Parameter                              | Test Conditions                            | Min. | Тур.  | Max. | Unit |
|-------------------|--|--|------|-------|------|------|
| <b>EMITTER</b>    |  |  |      |       |      |      |
| V <sub>F</sub>    | Input Forward Voltage                  | I <sub>F</sub> = 10 mA                     |      | 1.18  | 1.50 | V    |
| I <sub>R</sub>    | Reverse Leakage Current                | V <sub>R</sub> = 6.0 V                     |      | 0.001 | 10   | μΑ   |
| DETECTO           | DETECTOR                               |  |      |       |      |      |
| BV <sub>CEO</sub> | Collector-to-Emitter Breakdown Voltage | $I_C = 1.0 \text{ mA}, I_F = 0$            | 30   | 100   |      | V    |
| BV <sub>CBO</sub> | Collector-to-Base Breakdown Voltage    | $I_C = 100 \mu A, I_F = 0$                 | 70   | 120   |      | V    |
| BV <sub>ECO</sub> | Emitter-to-Collector Breakdown Voltage | $I_E = 100 \mu A, I_F = 0$                 | 7    | 10    |      | V    |
| I <sub>CEO</sub>  | Collector-to-Emitter Dark Current      | $V_{CE} = 10 \text{ V}, I_{F} = 0$         |      | 1     | 50   | nA   |
| I <sub>CBO</sub>  | Collector-to-Base Dark Current         | V <sub>CB</sub> = 10 V                     |      |       | 20   | nA   |
| C <sub>CE</sub>   | Capacitance                            | $V_{CE} = 0 \text{ V, } f = 1 \text{ MHz}$ |      | 8     |      | pF   |

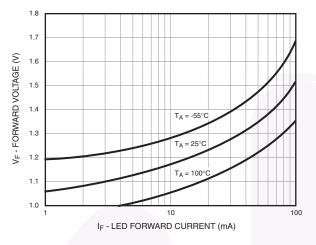
#### **Transfer Characteristics**

| Symbol               | Parameter                                       | Test Conditions   | Min. | Тур. | Max. | Unit |
|----------------------|---|---|------|------|------|------|
| DC CHAR              | ACTERISTICS                                     |   |      |      |      |      |
| CTR                  | Current Transfer Ratio,Collector-to-<br>Emitter | $I_F = 10 \text{ mA}, V_{CE} = 10 \text{ V}$  | 50   |      |      | %    |
| V <sub>CE(SAT)</sub> | Collector-to-Emitter Saturation Voltage         | $I_C = 0.5 \text{ mA}, I_F = 10 \text{ mA}$   |      |      | 0.4  | V    |
| AC CHAR              | AC CHARACTERISTICS                              |   |      |      |      |      |
| T <sub>ON</sub>      | Non-Saturated Turn-on Time                      | $I_F = 10 \text{ mA}, V_{CC} = 10 \text{ V},$<br>$R_L = 100 \Omega \text{ (Figure 13)}$ |      | 2    |      | μs   |
| T <sub>OFF</sub>     | Turn-off Time                                   | $I_F$ = 10 mA, $V_{CC}$ = 10 V,<br>$R_L$ = 100 Ω (Figure 13)                            |      | 2    |      | μs   |

#### **Isolation Characteristics**

| Symbol           | Characteristic                 | Test Conditions                                       | Min.             | Тур. | Max. | Unit               |
|------------------|--------------------------------|---|------------------|------|------|--------------------|
| V <sub>ISO</sub> | Input-Output Isolation Voltage | t = 1 Minute  | 4170             |      |      | VAC <sub>RMS</sub> |
| C <sub>ISO</sub> | Isolation Capacitance          | V <sub>I-O</sub> = 0 V, f = 1 MHz                     |                  | 0.2  |      | pF                 |
| R <sub>ISO</sub> | Isolation Resistance           | V <sub>I-O</sub> = ±500 VDC,<br>T <sub>A</sub> = 25°C | 10 <sup>11</sup> |      | y    | Ω                  |

### **Typical Performance Curves**



V<sub>CE</sub> = 5.0 V Normalized to I<sub>F</sub> = 10 mA

1.4

1.2

0.8

0.4

0.2

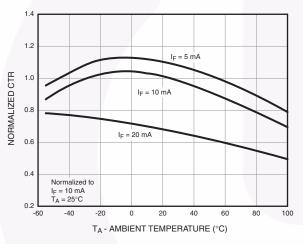
0.0

0 2 4 6 8 10 12 14 16 18 20

I<sub>F</sub> - FORWARD CURRENT (mA)

Figure 3. LED Forward Voltage vs. Forward Current

Figure 4. Normalized CTR vs. Forward Current



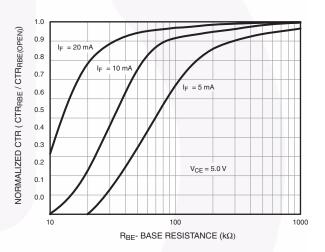
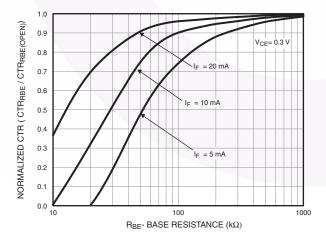


Figure 5. Normalized CTR vs. Ambient Temperature

Figure 6. CTR vs. RBE (Unsaturated)



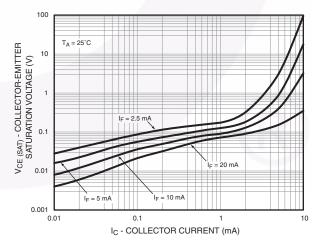


Figure 7. CTR vs. RBE (Saturated)

Figure 8. Collector-Emitter Saturation Voltage vs. Collector Current

## **Typical Performance Curves (Continued)**

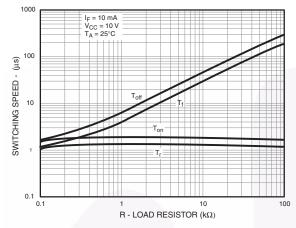


Figure 9. Switching Speed vs. Load Resistor

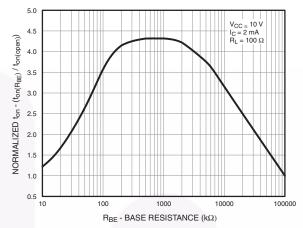


Figure 10. Normalized ton vs. RBE

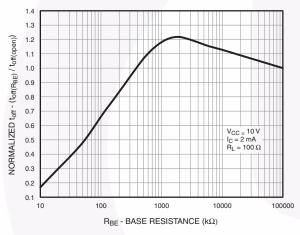


Figure 11. Normalized toff vs. RBE

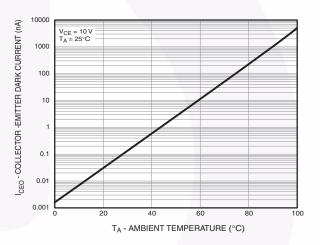


Figure 12. Dark Current vs. Ambient Temperature

## **Switching Time Test Circuit and Waveforms**

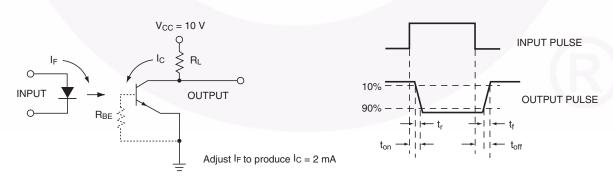


Figure 13. Switching Time Test Circuit and Waveforms

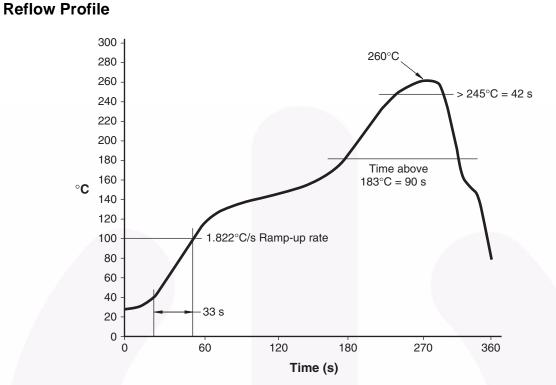


Figure 14. Reflow Profile

## **Ordering Information**

| Part Number | Package  | Packing Method             |
|-------------|--|----------------------------|
| H11A1M      | DIP 6-Pin  | Tube (50 Units)            |
| H11A1SM     | SMT 6-Pin (Lead Bend)                                    | Tube (50 Units)            |
| H11A1SR2M   | SMT 6-Pin (Lead Bend)                                    | Tape and Reel (1000 Units) |
| H11A1VM     | DIP 6-Pin, DIN EN/IEC60747-5-5 Option                    | Tube (50 Units)            |
| H11A1SVM    | SMT 6-Pin (Lead Bend), DIN EN/IEC60747-5-5 Option        | Tube (50 Units)            |
| H11A1SR2VM  | SMT 6-Pin (Lead Bend), DIN EN/IEC60747-5-5 Option        | Tape and Reel (1000 Units) |
| H11A1TVM    | DIP 6-Pin, 0.4" Lead Spacing, DIN EN/IEC60747-5-5 Option | Tube (50 Units)            |

## **Marking Information**

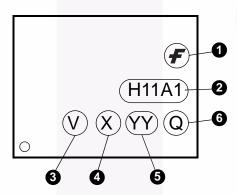
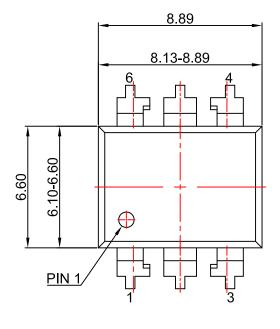
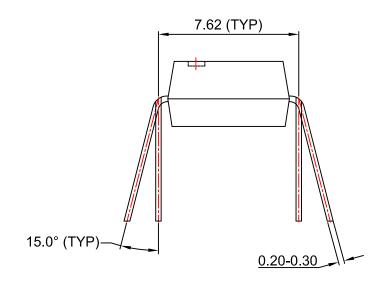


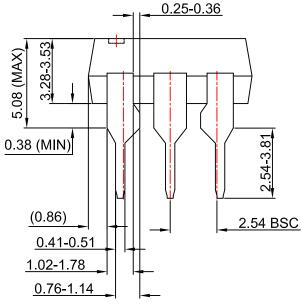
Figure 15. Top Mark

### **Table 1. Top Mark Definitions**

| 1 | Fairchild Logo  |
|---|---|
| 2 | Device Number   |
| 3 | DIN EN/IEC60747-5-5 Option (only appears on component ordered with this option) |
| 4 | One-Digit Year Code, e.g., "6"  |
| 5 | Digit Work Week, Ranging from "01" to "53"                                      |
| 6 | Assembly Package Code   |



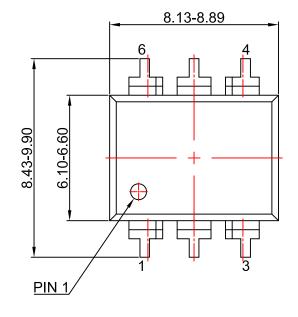


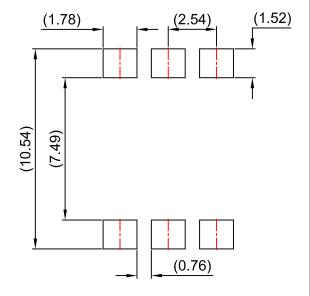


### NOTES:

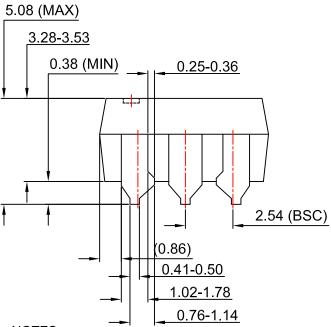
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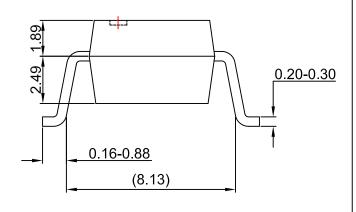






LAND PATTERN RECOMMENDATION

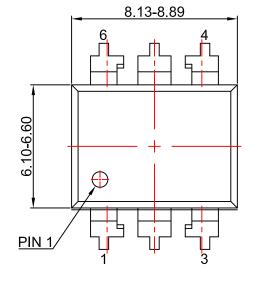


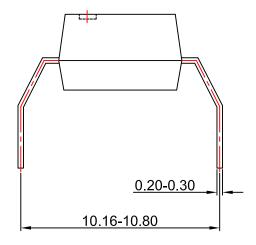


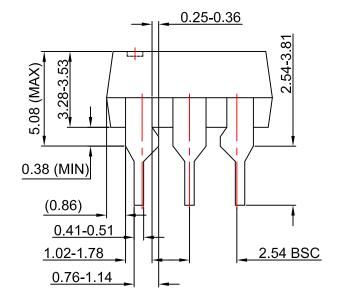
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